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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/700,473	SUEOKA ET AL.	
Examiner	Art Unit	
Alexis Wachtel	1764	

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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ALLOWANCE CONFERENCE G. CALDAGOLA	12/18/06	NB	